Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/840,737	WHITE, DAVID J.
Examiner	Art Unit
Maikhanh Nguyen	2176

SEARCHED					
Class	Subclass	Date	Examiner		
715	501.1 511	11/21/2007	МК		
715	517 522	11/21/2007	МК		
715	523 530	11/21/2007	мк		
			·		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	11/21/2007	MK		
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	11/21/2007	мк		
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